MOSFET – Power, N-Channel, SUPERFET[®] III, Automotive, Easy-Drive 650 V, 65 A, 40 mΩ

NVHL040N65S3

Description

SUPERFET III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provides superior switching performance, and withstand extreme dv/dt rate.

Consequently, SUPERFET III MOSFET Easy drive series helps manage EMI issues and allows for easier design implementation.

Features

- AEC-Q101 Qualified
- 700 V @ T_J = 150°C
- Typ. R_{DS(on)} = 35.4 mΩ
- Ultra Low Gate Charge (Typ. Q_g = 136 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 1154 pF)
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

Applications

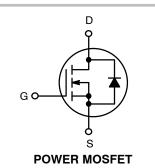
- Automotive On Board Charger
- Automotive DC/DC Converter for HEV



ON Semiconductor®

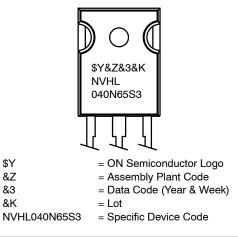
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V _{DSS}	R _{DS(ON)} MAX	I _D MAX	
650 V	40 m Ω @ 10 V	65 A	





MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

Symbol	Parameter		Value	Unit	
V _{DSS}	Drain to Source Voltage		650	V	
V _{GSS}	Gate to Source Voltage	– DC	±30	V	
		– AC (f > 1 Hz)	±30		
ID	Drain Current	– Continuous (T _C = 25°C)	65	А	
		– Continuous (T _C = 100°C)	41		
I _{DM}	Drain Current	– Pulsed (Note 1)	162.5	А	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		358	mJ	
I _{AS}	Avalanche Current (Note 2)		8.1	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)		4.17	mJ	
dv/dt	MOSFET dv/dt		100	V/ns	
	Peak Diode Recovery dv/dt (Note 3)		20		
P _D	Power Dissipation	(T _C = 25°C)	417	W	
		- Derate Above 25°C	3.33	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
ΤL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 seconds		300	°C	

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, Unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Repetitive rating: pulse width limited by maximum junction temperature. 2. $I_{AS} = 8.1 \text{ A}, R_G = 25 \Omega$, starting $T_J = 25^{\circ}C$. 3. $I_{SD} \leq 32.5 \text{ A}, \text{ di/dt} \leq 200 \text{ A/}\mu\text{s}, V_{DD} \leq 400 \text{ V}, \text{ starting } T_J = 25^{\circ}C$.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	R _{θJC} Thermal Resistance, Junction to Case, Max.		°C/W
$R_{\theta JA}$	R _{0JA} Thermal Resistance, Junction to Ambient, Max.		

PACKAGE MARKING AND ORDERING INFORMATION

Part Number	Top Marking	Package	Packing Method	Reel Size	Tape Width	Quantity
NVHL040N65S3	NVHL040N65S3	TO-247 G03	Tube	N/A	N/A	30 Units

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Symbol Parameter Test Conditions Min Typ Max Unit							
Symbol	Falametei	Test conditions	WIIII	тур	WIGA	Unit	
OFF CHARACT	ERISTICS						
BV _{DSS}	Drain to Source Breakdown Voltage	V_{GS} = 0 V, I_D = 1 mA, T_J = 25°C	650	-	-	V	
		V_{GS} = 0 V, I_D = 1 mA, T_J = 150°C	700	-	-	V	
$\Delta \text{BV}_{\text{DSS}} / \Delta \text{T}_{\text{J}}$	Breakdown Voltage Temperature Coefficient	$I_D = 1$ mA, Referenced to 25°C	-	0.64	-	V/°C	
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μΑ	
		V_{DS} = 520 V, T_{C} = 125°C	-	4.5	-		
I _{GSS}	Gate to Body Leakage Current	V_{GS} = ±30 V, V_{DS} = 0 V	-	-	±100	nA	
ON CHARACTE	RISTICS						
V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 1.7$ mA	2.5	-	4.5	V	
R _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 32.5 A	-	35.4	40	mΩ	
9 FS	Forward Transconductance	$V_{DS} = 20 \text{ V}, \text{ I}_{D} = 32.5 \text{ A}$	-	46	-	S	

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
YNAMIC CH	ARACTERISTICS	· · · · · ·				
C _{iss}	Input Capacitance	V_{DS} = 400 V, V_{GS} = 0 V, f = 1 MHz	-	4740	-	pF
C _{oss}	Output Capacitance		-	120	-	pF
C _{oss(eff.)}	Effective Output Capacitance	V_{DS} = 0 V to 400 V, V_{GS} = 0 V	-	1154	-	pF
C _{oss(er.)}	Energy Related Output Capacitance	V_{DS} = 0 V to 400 V, V_{GS} = 0 V	-	171	-	pF
Q _{g(tot)}	Total Gate Charge at 10 V	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 32.5 \text{ A}, \text{ V}_{GS} = 10 \text{ V}$	-	136	-	nC
Q _{gs}	Gate to Source Gate Charge	(Note 4)	-	33	-	nC
Q _{gd}	Gate to Drain "Miller" Charge		-	59	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	0.7	-	Ω
WITCHING C	HARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 400 \text{ V}, \text{ I}_{D} = 32.5 \text{ A},$	-	35	-	ns
t _r	Turn-On Rise Time	V _{GS} = 10 V, R _g = 3.3 Ω (Note 4)	-	51	-	ns
t _{d(off)}	Turn-Off Delay Time		-	95	-	ns
t _f	Turn-Off Fall Time		-	30	-	ns
OURCE-DRA	IN DIODE CHARACTERISTICS					-
۱ _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	65	А
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	162.5	Α
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _{SD} = 32.5 A	-	-	1.2	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 V, I_{SD} = 32.5 A,$	-	534	-	ns
Qrr	Reverse Recovery Charge	dI _F /dt = 100 A/µs	_	13.6	_	uС

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Essentially independent of operating temperature typical characteristics.

13.6

μC

Reverse Recovery Charge

Q_{rr}

TYPICAL PERFORMANCE CHARACTERISTICS

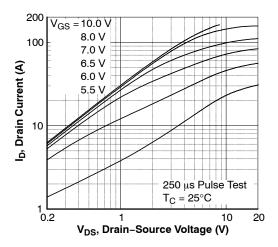


Figure 1. On–Region Characteristics 25°C

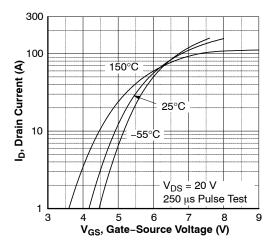
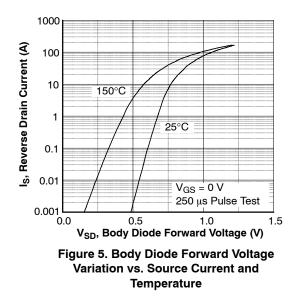


Figure 3. Transfer Characteristics



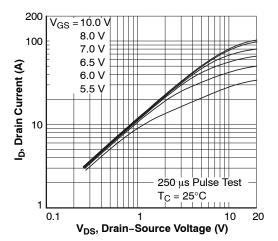


Figure 2. On–Region Characteristics 150°C

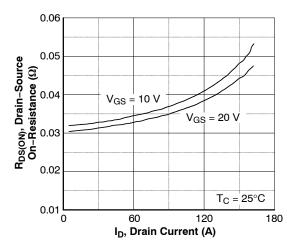
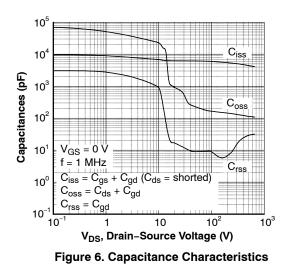


Figure 4. On-Resistance Variation vs. Drain Current and Gate Voltage



TYPICAL PERFORMANCE CHARACTERISTICS (continued)

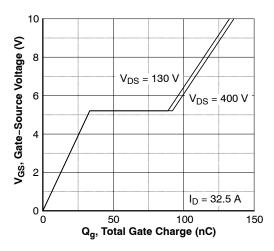


Figure 7. Gate Charge Characteristics

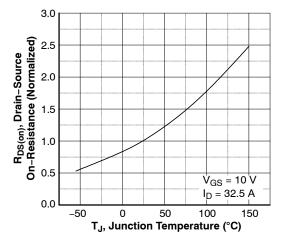


Figure 9. On–Resistance Variation vs. Temperature

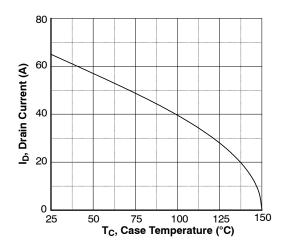


Figure 11. Maximum Drain Current vs. Case Temperature

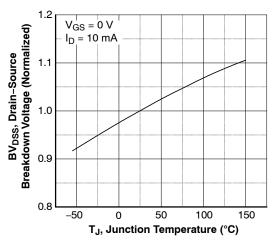


Figure 8. Breakdown Voltage Variation vs. Temperature

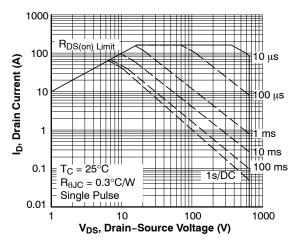


Figure 10. Maximum Safe Operating Area

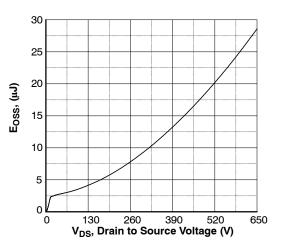
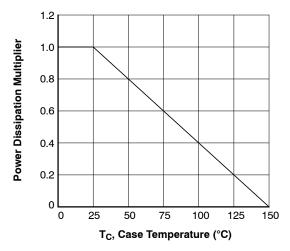


Figure 12. E_{OSS} vs. Drain to Source Voltage

TYPICAL PERFORMANCE CHARACTERISTICS (continued)





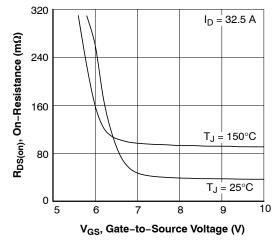


Figure 15. R_{DS(on)} vs. Gate Voltage Figure

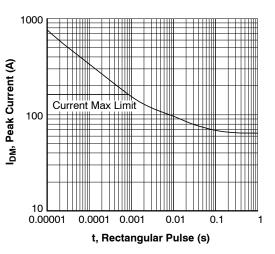


Figure 14. Peak Current Capability

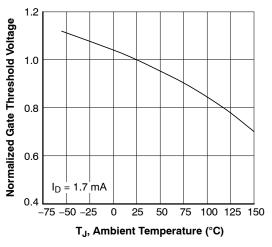


Figure 16. Normalized Gate Threshold Voltage vs. Temperature

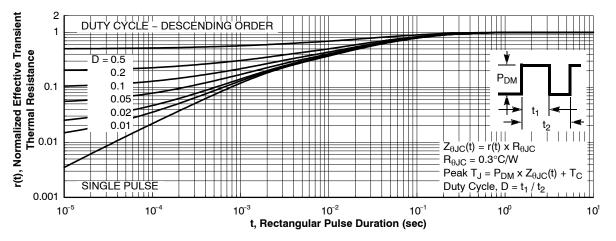
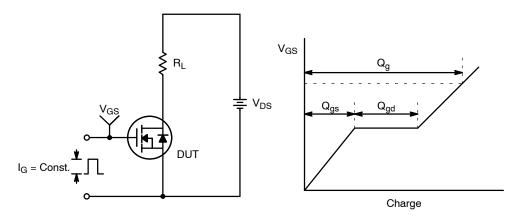


Figure 17. Transient Thermal Response Curve





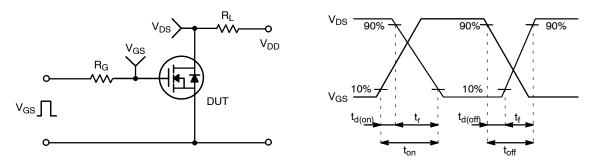
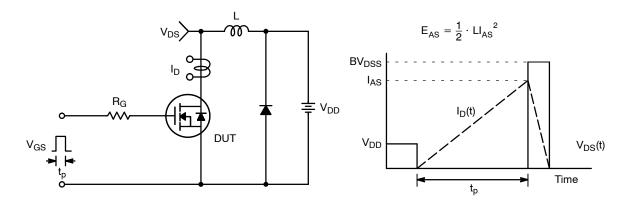


Figure 19. Resistive Switching Test Circuit & Waveforms





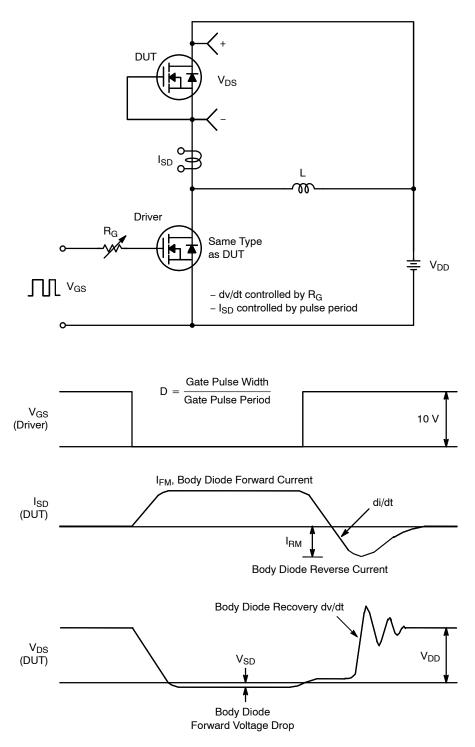
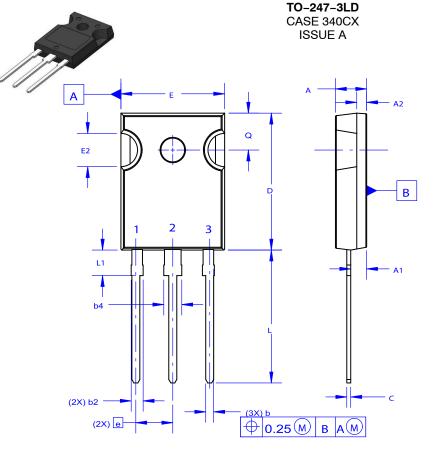


Figure 21. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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NOTES: UNLESS OTHERWISE SPECIFIED.

- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

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GENERIC **MARKING DIAGRAM*** Х



XXXXX	= Specific Device Code
Α	= Assembly Location

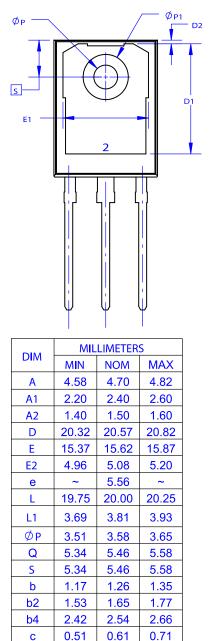
- = Assembly Location
- = Year
- ww = Work Week
- G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ", may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	TO-247-3LD		PAGE 1 OF 1

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DATE 06 JUL 2020



D1

D2

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